

ATF1504ASV/ATF1504ASVL

ATF1504ASV(L) 3.3V 64-Macrocell CPLD Data Sheet

Features

- High-Density, High-Performance, Electrically-Erasable Complex Programmable Logic Device:
 - 3.0V to 3.6V operating range
 - 64 macrocells
 - 5 product terms per macrocell, expandable up to 40 per macrocell
 - 44 and 100 pins
 - 15 ns maximum pin-to-pin delay
 - Registered operation up to 77 MHz
 - Enhanced routing resources
- In-System Programmability (ISP) via JTAG
- Flexible Logic Macrocell:
 - D/T/Latch configurable flip-flops
 - Global and individual register control signals
 - Global and individual output enable
 - Programmable output slew rate
 - Programmable output open-collector option
 - Maximum logic utilization by burying a register with a COM output
- Advanced Power Management Features:
 - Automatic 5 µA Standby (ATF1504ASVL)
 - Pin-controlled 100 µA Standby mode (typical)
 - Programmable pin-keeper circuits on inputs and I/Os
 - Reduced-power feature per macrocell
- Available in Industrial Temperature Range
- Robust EEPROM Technology:
 - 100% tested
 - Completely reprogrammable
 - 10,000 Program/Erase cycles
 - 20-year data retention
 - 2000V ESD protection
 - 200 mA latch-up immunity
- JTAG Boundary-Scan Testing to IEEE Std. 1149.1-1990 and 1149.1a-1993 Supported
- PCI-Compliant
- Security Fuse Feature
- Green (Pb/Halide-Free/RoHS Compliant)
 Package Options

Enhanced Features

- Improved Connectivity (Additional Feedback Routing, Alternate Input Routing)
- Output Enable Product Terms
- Transparent-Latch Mode
- Combinatorial Output with Registered Feedback
 within any Macrocell
- Three Global Clock Pins
- ITD (Input Transition Detection) Circuits on Global Clocks, Inputs and I/O
- Fast Registered Input from Product Term
- · Programmable "Pin-keeper" Option
- Vcc Power-Up Reset Option
- Pull-Up Option on JTAG Pins (TMS and TDI)
- Advanced Power Management Features:
 Edge-controlled power-down
 - (ATF1504ASVL)
 Individual macrocell power option
 - Disable ITD on global clocks

Packages

- 44-Lead PLCC
- · 44-Lead and 100-Lead TQFP

Description

The ATF1504ASV(L) is a high-performance, high-density complex programmable logic device (CPLD) that utilizes Microchip's proven electrically-erasable memory technology. With 64 logic macrocells and up to 68 inputs and I/Os, it easily integrates logic from several TTL, SSI, MSI, LSI and classic PLDs. The ATF1504ASV(L)'s enhanced routing switch matrices increase usable gate count and the odds of successful pin-locked design modifications.

The ATF1504ASV(L) has up to 64 bidirectional I/O pins and four dedicated input pins, depending on the type of device package selected. Each dedicated pin can also serve as a global control signal (register clock, register Reset or output enable). Each of these control signals can be selected for use individually within each macrocell. Each of the 64 macrocells generates a buried feedback that goes to the global bus. Each input and I/O pin also feeds into the global bus. The switch matrix in each logic block then selects 40 individual signals from the global bus. Each macrocell also generates a foldback logic term that goes to a regional bus.

Cascade logic between macrocells in the ATF1504-ASV(L) allows fast, efficient generation of complex logic functions. The ATF1504ASV(L) contains four such logic chains, each capable of creating sum term logic with a fan-in of up to 40 product terms.

The ATF1504ASV(L) macrocell (see ATF1504ASV(L) Macrocell), is flexible enough to support highly complex logic functions operating at high speed. The macrocell consists of five sections: product terms and product term select multiplexer, OR/XOR/CASCADE logic, a flip-flop, output select and enable, and logic array inputs.



ATF1504ASV(L) Macrocell

Pin Configurations and Pinouts



ATF1504ASV/ATF1504ASVL

Block Diagram



Unused product terms are automatically disabled by the compiler to decrease power consumption. A security fuse, when programmed, protects the contents of the ATF1504ASV(L). Two bytes (16 bits) of User Signature are accessible to the user for purposes such as storing project name, part number, revision or date. The User Signature is accessible regardless of the state of the security fuse.

The ATF1504ASV(L) device is an in-system programmable (ISP) device. It uses the industry-standard 4-pin JTAG interface (IEEE Std. 1149.1), and is fully compliant with JTAG's Boundary-scan Description Language (BSDL). ISP allows the device to be programmed without removing it from the printed circuit board. In addition to simplifying the manufacturing flow, ISP also allows design modifications to be made in the field via software.

PRODUCT TERMS AND SELECT MUX

Each ATF1504ASV(L) macrocell has five product terms. Each product term receives as its inputs all signals from both the global bus and regional bus.

The product term select multiplexer (PTMUX) allocates the five product terms as needed to the macrocell logic gates and control signals. The PTMUX programming is determined by the design compiler, which selects the optimum macrocell configuration.

OR/XOR/CASCADE LOGIC

The ATF1504ASV(L)'s logic structure is designed to efficiently support all types of logic. Within a single macrocell, all the product terms can be routed to the OR gate, creating a 5-input AND/OR sum term. With the addition of the CASIN from neighboring macrocells, this can be expanded to as many as 40 product terms with little additional delay.

The macrocell's XOR gate allows efficient implementation of compare and arithmetic functions. One input to the XOR comes from the OR sum term. The other XOR input can be a product term or a fixed high- or low-level. For combinatorial outputs, the fixed level input allows polarity selection. For registered functions, the fixed levels allow DeMorgan minimization of product terms. The XOR gate is also used to emulate T- and JK-type flip-flops.

FLIP-FLOP

The ATF1504ASV(L)'s flip-flop has very flexible data and control functions. The data input can come from either the XOR gate, from a separate product term or directly from the I/O pin. Selecting the separate product term allows creation of a buried registered feedback within a combinatorial output macrocell. (This feature is automatically implemented by the fitter software).

In addition to D, T, JK and SR operation, the flip-flop can also be configured as a flow-through latch. In this mode, data passes through when the clock is high and is latched when the clock is low.

The clock itself can either be one of the Global CLK Signal (GCK[0:2]) or an individual product term. The flip-flop changes state on the clock's rising edge. When the GCK signal is used as the clock, one of the macrocell product terms can be selected as a clock enable. When the clock enable function is active and the enable signal (product term) is low, all clock edges are ignored. The flip-flop's asynchronous Reset signal (AR) can be either the Global Clear (GCLEAR), a product term, or always off. AR can also be a logic OR of GCLEAR with a product term. The asynchronous preset (AP) can be a product term or always off.

EXTRA FEEDBACK

The ATF1504ASV(L) macrocell output can be selected as registered or combinatorial. The extra buried feedback signal can be either combinatorial or a registered signal regardless of whether the output is combinatorial or registered. (This enhancement function is automatically implemented by the fitter software.) Feedback of a buried combinatorial output allows the creation of a second latch within a macrocell.

I/O CONTROL

The output enable multiplexer (MOE) controls the output enable signal. Each I/O can be individually configured as an input, output or for bidirectional operation. The output enable for each macrocell can be selected from the true or compliment of the two output enable pins, a subset of the I/O pins, or a subset of the I/O macrocells. This selection is automatically done by the fitter software when the I/O is configured as an input, all macrocell resources are still available, including the buried feedback, expander and cascade logic.

GLOBAL BUS/SWITCH MATRIX

The global bus contains all input and I/O pin signals as well as the buried feedback signal from all 64 macrocells. The switch matrix in each logic block receives as its inputs all signals from the global bus. Under software control, up to 40 of these signals can be selected as inputs to the logic block.

FOLDBACK BUS

Each macrocell also generates a foldback product term. This signal goes to the regional bus and is available to four macrocells. The foldback is an inverse polarity of one of the macrocell's product terms. The four foldback terms in each region allow generation of high fan-in sum terms (up to nine product terms) with little additional delay.

Programmable Pin-Keeper Option for Inputs and I/Os

The ATF1504ASV(L) offers the option of programming all input and I/O pins so that pin-keeper circuits can be utilized. When any pin is driven high or low and then subsequently left floating, it will stay at that previous high or low level. This circuitry prevents unused input and I/O lines from floating to intermediate voltage levels, which causes unnecessary power consumption and system noise. The keeper circuits eliminate the need for external pull-up resistors and eliminate their DC power consumption.

ATF1504ASV/ATF1504ASVL





I/O Diagram



Speed/Power Management

The ATF1504ASV(L) has several built-in speed and power management features. The ATF1504ASVL contains circuitry that automatically puts the device into a low-power Standby mode when no logic transitions are occurring. This not only reduces power consumption during inactive periods, but also provides proportional power savings for most applications running at system speeds below 5 MHz.

To further reduce power, each ATF1504ASV(L) macrocell has a reduced-power bit feature. This feature allows individual macrocells to be configured for maximum power savings. This feature may be selected as a design option. All ATF1504ASV(L) also have an optional Power-Down mode. In this mode, current drops to below 5 mA. When the power-down option is selected, either PD1 or PD2 pins (or both) can be used to power down the part. The power-down option is selected in the design software or design source file. When enabled, the device goes into power-down when either PD1 or PD2 is high. In the Power-Down mode, all internal logic signals are latched and held, as are any enabled outputs.

All pin transitions are ignored until the PD pin is brought low. When the power-down feature is enabled, the PD1 or PD2 pin cannot be used as a logic input or output. However, the pin's macrocell may still be used to generate buried foldback and cascade logic signals. All power-down AC characteristic parameters are computed from external input or I/O pins, with reduced-power bit turned on. For macrocells in Reduced-Power mode (reduced-power bit turned on), the reduced-power adder, tRPA, must be added to the AC parameters, which include the data paths tLAD, tLAC, tIC, tACL or tACH, tEN and tSEXP.

The ATF1504ASV(L) macrocell also has an option whereby the power can be reduced on a per macrocell basis. By enabling this power-down option, macrocells that are not used in an application can be turned down, thereby reducing the overall power consumption of the device. This option is automatically set by the device fitter software.

Each output also has individual slew rate control. This may be used to reduce system noise by slowing down outputs that do not need to operate at maximum speed. Outputs default to slow switching, and may be specified as fast switching in the design software or design file.

Design Software Support

ATF1504ASV(L) designs are supported by Microchip's ProChip Designer and WinCUPL software tools as well as Precision Synthesis from Mentor Graphic as described in the "Programmable Logic Device Design Software Overview".

Power-Up Reset

The ATF1504ASV/ATF1504ASVL is designed with a power-up Reset, a feature critical for state machine initialization. At a point delayed slightly from Vcc crossing VRST, all registers will be initialized, and the state of each output will depend on the polarity of its buffer. However, due to the asynchronous nature of Reset and uncertainty of how Vcc actually rises in the system, the following conditions are required:

- The Vcc rise must be monotonic
- After Reset occurs, all input and feedback setup times must be met before driving the clock pin high
- The clock must remain stable during Power-up Reset

The ATF1504ASV/ATF1504ASVL has two options for the hysteresis about the Reset level, VRST, Small and Large. To ensure a robust operating environment in applications where the device is operated near 3.0V, it is recommended that during the fitting process users configure the device with the Power-up Reset hysteresis set to Large. Users of the POF2JED conversion utility should include the flag "-power_reset" on the command line after "filename.POF". To allow the registers to be properly reinitialized with the Large hysteresis option selected, the following condition is added:

• If Vcc falls below 2.0V, it must shut off completely before the device is turned on again

When the Large hysteresis option is active, ICC is reduced by several hundred microamps as well.

Details on the power Reset hysteresis feature are available in the "ATF15XX Power-on Reset Hysteresis Feature" application note.

Security Fuse Usage

A single fuse is provided to prevent unauthorized copying of the ATF1504ASV(L) fuse patterns. Once programmed, fuse verify is inhibited. However, the 16-bit User Signature remains accessible.

Programming

ATF1504ASV(L) devices are in-system programmable (ISP) devices utilizing the 4-pin JTAG protocol. This capability eliminates package handling normally required for programming and facilitates rapid design iterations and field changes.

Microchip provides ISP hardware and software to allow programming of the ATF1504ASV(L) via the PC. ISP is performed by using either a download cable, a comparable board tester or a simple microprocessor interface.

To facilitate ISP programming by the Automated Test Equipment (ATE) vendors, Serial Vector Format (SVF) files can be created by Microchip provided software utilities.

ATF1504ASV(L) devices can also be programmed using standard third-party programmers. With a third-party programmer, the JTAG ISP port can be disabled, thereby allowing four additional I/O pins to be used for logic.

Refer to Programming of PLDs application note for more details.

ISP Programming Protection

The ATF1504ASV(L) has a special feature that locks the device and prevents the inputs and I/O from driving if the programming process is interrupted for any reason. The inputs and I/O default to high Z state during such a condition. In addition, the pin-keeper option preserves the former state during device programming, if this circuit was previously programmed on the device. This prevents disturbing the operation of other circuits in the system while the ATF1504ASV(L) is being programmed via ISP.

All ATF1504ASV(L) devices are initially shipped in the erased state, thereby making them ready to use for ISP.

1.0 ELECTRICAL SPECIFICATIONS

Absolute Maximum Ratings (†)

Temperature under bias	40°C to +85°C
Storage temperature	-65°C to +150°C
Voltage on any pin with respect to ground ⁽¹⁾	-2.0V to +7.0V

† NOTICE: Stresses above those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress rating only and functional operation of the device at those or any other conditions above those indicated in the operational listings of this specification is not implied. Exposure to maximum rating conditions for extended periods may affect device reliability.

Note 1: Minimum voltage is -0.6V DC, which may undershoot to -2.0V for pulses of less than 20 ns. Maximum output pin voltage is Vcc + 0.75V DC, which may overshoot to 7.0V for pulses of less than 20 ns.

TABLE 1-1: DC AND AC OPERATING CONDITIONS

	Industrial
Operating Temperature (Ambient)	-40°C to +85°C
Vcc (Vccio/Vccint) Power Supply	3.0V to 3.6V

TABLE 1-2: DC CHARACTERISTICS

Symbol	Parameter	Minimum	Typical	Maximum	Units	Condit	tion
lıL	Input or I/O Low Leakage Current	—	-2	-10	μA	VIN = GND	
Іін	Input or I/O High Leakage Current	—	2	10	μA	VIN = VCC	
loz	Tri-State Output Off-State Current	-40	—	40	μA	Vo = Vcc or GN	D
ICC1	Power Supply Current, Standby	—	75	—	mA	Vcc = Max Vin = 0, Vcc	Std power
		—	5	—	μA	Vcc = Max Vin = 0, Vcc	"L" power
Icc2	Power Supply Current, Power-Down mode	_	0.1	5	mA	Vcc = Max Vin = 0, Vcc	"PD" mode
ICC3 ⁽¹⁾	Reduced Power mode Supply Current, Standby	—	55	—	mA	Vcc = Max Vin = 0, Vcc	Std power
VIL	Input Low Voltage	-0.3	_	0.8	V		
VIH	Input High Voltage	1.7	_	Vccio + 0.3	V		
Vol	Output Low Voltage (3.3V TTL)	—	—	0.45	V	VIN = VIH or VIL VCCIO = Min, IOI	∟ = 8 mA
	Output Low Voltage (3.3V CMOS)	—	—	0.2	V	VIN = VIH or VIL VCCIO = Min, IOL = 0.1 mA	
Voн	Output High Voltage (3.3V TTL)	2.4	—		V	VIN = VIH or VIL VCCIO = Min, IOH = -1.5 mA	
	Output High Voltage (3.3V CMOS)	Vccio - 0.2	—		V	VIN = VIH or VIL VCCIO = Min, IOI	н = -0.1 mA

Note 1: When macrocell reduced-power feature is enabled.

	Typical	Maximum	Units	Conditions
Cin	—	8	pF	VIN = 0V; f = 1.0 MHz
Cı/o	—	8	pF	Vout = 0V; f = 1.0 MHz

Note 1: Typical values for nominal supply voltage. This parameter is only sampled and is not 100% tested.

2: The OGI pin (high-voltage pin during programming) has a maximum capacitance of 12 pF.

Timing Model



Symbol	Parameter	-15		-20		Units
Symbol	Symbol Farameter		Max.	Min.	Max.	Units
tPD1	Input or Feedback to Non-Registered Output	3	15	—	20	ns
tPD2	I/O Input or Feedback to Non-Registered Feedback	3	12	—	16	ns
tsu	Global Clock Setup Time	11	—	13.5	—	ns
tн	Global Clock Hold Time	0	_	0	_	ns
tFSU	Global Clock Setup Time of Fast Input	3	_	3	_	ns
tғн	Global Clock Hold Time of Fast Input	1.0	_	2	_	ns
tCOP	Global Clock to Output Delay	_	9	_	12	ns
tсн	Global Clock High Time	5	_	6	_	ns
tCL	Global Clock Low Time	5	_	6	_	ns
tasu	Array Clock Setup Time	5	_	7	_	ns
tан	Array Clock Hold Time	4	_	4	_	ns
tacop	Array Clock Output Delay	_	15	_	18.5	ns
tасн	Array Clock High Time	6	_	8	—	ns

Symbol	Parameter	-	15	-2	20	Units
Symbol	Farameter		Max.	Min.	Max.	Units
tacl	Array Clock Low Time	6		8	_	ns
t CNT	Minimum Clock Global Period	_	13	_	17	ns
fCNT	Maximum Internal Global Clock Frequency	76.9	_	66	_	MHz
t ACNT	Minimum Array Clock Period	_	13	_	17	ns
f ACNT	Maximum Internal Array Clock Frequency	76.9	_	58.8	_	MHz
fMAX	Maximum Clock Frequency	100	_	83.3	_	MHz
tin	Input Pad and Buffer Delay	_	2	_	2.5	ns
tio	I/O Input Pad and Buffer Delay	_	2	_	2.5	ns
tfin	Fast Input Delay	_	2	_	2	ns
tSEXP	Foldback Term Delay		8	_	10	ns
t PEXP	Cascade Logic Delay	_	1	—	1	ns
tlad	Logic Array Delay	_	6	—	8	ns
tLAC	Logic Control Delay	_	3.5	_	4.5	ns
tioe	Internal Output Enable Delay	_	3	_	3	ns
tod1	Output Buffer and Pad Delay (Slow slew rate = OFF; Vccio = 3.3V; CL = 35 pF)	_	3	_	4	ns
tod3	Output Buffer and Pad Delay (Slow slew rate = ON; Vccio = 3.3V; CL = 35 pF)	_	5		6	ns
tzx1	Output Buffer Enable Delay (Slow slew rate = OFF; Vccio = 3.3V; CL = 35 pF)	_	7	_	9	ns
tzx3	Output Buffer Enable Delay (Slow slew rate = ON; Vccio = 3.3V; CL = 35 pF)	_	10	_	11	ns
txz	Output Buffer Disable Delay (C∟ = 5 pF)	_	6	_	7	ns
tsu	Register Setup Time	5	_	6	_	ns
tн	Register Hold Time	4	—	5	_	ns
tFSU	Register Setup Time of Fast Input	2	—	2	_	ns
tFH	Register Hold Time of Fast Input	2		2	_	ns
tRD	Register Delay	—	2	_	2.5	ns
tсомв	Combinatorial Delay	_	2	—	3	ns
tıc	Array Clock Delay	_	6	—	7	ns
ten	Register Enable Time	—	6	—	7	ns
tglob	Global Control Delay		2	_	3	ns
t PRE	Register Preset Time		4	_	5	ns
tCLR	Register Clear Time	—	4	_	5	ns
tuim	Switch Matrix Delay	1_	2	_	2.5	ns

TABLE 1-4: AC CHARACTERISTICS (CONTINUED)

TABLE 1-4: AC CHARACTERISTICS (CONTINUED)

Symbol	Parameter		-15		-20	
		Min.	Max.	Min.	Max.	Units
trpa	Reduced-Power Adder ⁽¹⁾		10		13	ns

Note 1: The tRPA parameter must be added to the tLAD, tLAC, tIC, tACL or tACH, tEN and tSEXP parameters for macrocells running in the Reduced-Power mode.

FIGURE 1-1: INPUT TEST WAVEFORMS AND MEASUREMENT LEVELS



FIGURE 1-2: OUTPUT AC TEST LOADS



Power-Down Mode

The ATF1504ASV(L) includes an optional pin-controlled power-down feature. When this mode is enabled, the PD pin acts as the power-down pin. When the PD pin is high, the device supply current is reduced to less than 5 mA. During power-down, all output data and internal logic states are latched internally and held. Therefore, all registered and combinatorial output data remain valid. Any outputs that were in a high Z state at the onset will remain at high Z. During power-down, all input signals except the Power-Down pin are blocked. Input and I/O hold latches remain active to ensure that pins do not float to indeterminate levels, further reducing system power. The Power-Down mode feature is enabled in the logic design file or as a design software option. Designs using the Power-Down pin may not use the PD pin as a logic array input. However, all other PD pin macrocell resources may still be used, including the buried feedback and foldback product term array inputs.

TABLE 1-5: POWER-DOWN AC CHARACTERISTICS ⁽¹⁾⁽²⁾⁽²⁾

Symbol	Symbol Parameter		-15		-20	
Symbol			Max.	Min.	Max.	Units
tivdh	Valid I, I/O before PD High	15	—	20		ns
t GVDH	Valid OE ⁽²⁾ before PD High	15	_	20		ns
t CVDH	Valid Clock ⁽²⁾ before PD High	15	—	20		ns
t DHIX	I, I/O Don't Care after PD High	_	25	_	30	ns
t DHGX	OE ⁽²⁾ Don't Care after PD High	_	25	_	30	ns
t DHCX	Clock ⁽²⁾ Don't Care after PD High	—	25	—	30	ns
tdliv	PD Low to Valid I, I/O	_	1	_	1	μs
tDLGV	PD Low to Valid OE (Pin or Term)	_	1	_	1	μs
t DLCV	PD Low to Valid Clock (Pin or Term)	_	1	_	1	μs
t DLOV	PD Low to Valid Output	_	1	_	1	μs

Note 1: For slow slew outputs, add tsso.

- **2:** Pin or product term.
- 3: Includes tRPA for reduced-power bit enabled.

JTAG-BST/ISP Overview

The JTAG boundary-scan testing is controlled by the Test Access Port (TAP) controller in the ATF1504-ASV(L). The boundary-scan technique involves the inclusion of a shift-register stage (contained in a bound-ary-scan cell) adjacent to each component so that signals at component boundaries can be controlled and observed using scan testing principles. Each input pin and I/O pin has its own boundary-scan cell (BSC) in order to support boundary-scan testing.

The ATF1504ASV(L) does not include a Test Reset (TRST) input pin because the TAP controller is automatically reset at power-up. The five JTAG modes supported include: SAMPLE/PRELOAD, EXTEST, BYPASS, IDCODE and HIGHZ. The ATF1504ASV(L)'s ISP can be fully described using JTAG's BSDL as described in IEEE Standard 1149.1. This allows ATF1504ASV(L) programming to be described and implemented using any one of the third-party development tools supporting this standard.

The ATF1504ASV(L) has the option of using four JTAG-standard I/O pins for boundary-scan testing (BST) and in-system programming (ISP) purposes. The ATF1504ASV(L) is programmable through the four JTAG pins using the IEEE standard JTAG programming protocol established by IEEE Standard 1149.1 using 3.3V TTL/CMOS-level programming signals from the ISP interface for in-system programming. The JTAG feature is a programmable option. If JTAG (BST or ISP) is not needed, then the four JTAG control pins are available as I/O pins.

JTAG Boundary-Scan Cell (BSC)

The ATF1504ASV(L) contains up to 64 I/O pins and four input pins, depending on the device type and package type selected. Each input pin and I/O pin has its own boundary-scan cell (BSC) in order to support boundary-scan testing as described in detail by IEEE Standard 1149.1. A typical BSC consists of three capture registers or scan registers and up to two update registers.

There are two types of BSCs, one for input or I/O pin, and one for the macrocells. The BSCs in the device are chained together through the capture registers. Input to the capture register chain is fed in from the TDI pin while the output is directed to the TDO pin. Capture registers are used to capture active device data signals, to shift data in and out of the device and to load data into the update registers. Control signals are generated internally by the JTAG TAP controller. The BSC configuration for the input and I/O pins and macrocells are shown in Figure 1-3 and Figure 1-4.









Dedicated Pin	44-Lead TQFP	44-Lead J-lead	100-Lead TQFP
INPUT/OE2 ⁽¹⁾ /GCLK2 ⁽²⁾	40	2	90
INPUT/GCLR ⁽³⁾	39	1	89
INPUT/OE1 ⁽¹⁾	38	44	88
INPUT/GCLK1 ⁽²⁾	37	43	87
I/O /GCLK3 ⁽²⁾	35	41	85
I/O / PD (1,2) ⁽⁴⁾	5, 19	11, 25	12, 42
I/O / TDI (JTAG) ⁽⁵⁾	1	7	4
I/O / TMS (JTAG) ⁽⁵⁾	7	13	15
I/O / TCK (JTAG) ⁽⁵⁾	26	32	62
I/O / TDO (JTAG) ⁽⁵⁾	32	38	73
GND ⁽⁶⁾	4, 16, 24, 36	10, 22, 30, 42	11, 26, 38, 43, 59, 74, 86, 95
Vcc ⁽⁷⁾	9, 17, 29, 41	3, 15, 23, 35	3, 18, 34, 39, 51, 66, 82, 91
N/C	_	_	1, 2, 5, 7, 22, 24, 27, 28, 49, 50, 53, 55, 70, 72, 77, 78
# of Signal Pins	36	36	68
# User I/O Pins	32	32	64

TABLE 1-6: DEDICATED PINOUTS

- Note 1: OE (1, 2)
- = Global OE pins
- **2:** GCLK (1, 2, 3) = Global Clock pins
- **3**: GCLR = Global Clear pin
- **4:** PD (1, 2) = Power-Down pins
- 5: TDI, TMS, TCK. TDO = JTAG pins used for boundary-scan testing or in-system programming
- 6: GND
- = Ground pins
- 7: Vcc
- = Vcc (VccINT/VccIO) pins for the device

МС	PLC	44-Lead PLCC	44-Lead TQFP	100-Lead TQFP	МС	PLC	44-Lead PLCC	44-Lead TQFP	100-Lead TQFP
1	Α	12	6	14	33	С	24	18	40
2	А		_	13	34	С		_	41
3	A/PD1	11	5	12	35	C/ PD2	25	19	42
4	А	9	3	10	36	С	26	20	44
5	А	8	2	9	37	С	27	21	45
6	А	—	-	8	38	С	—	—	46
7	А	—	-	6	39	С	-	—	47
8/TDI	А	7	1	4	40	С	28	22	48
9	А	—		100	41	С	29	23	52
10	А	—	-	99	42	С	-	—	54
11	А	6	44	98	43	С	—	—	56
12	А	—		97	44	С	_	—	57
13	А	—	-	96	45	С	-	—	58
14	А	5	43	94	46	С	31	25	60
15	А	—		93	47	С	_	—	61
16	А	4	42	92	48/ TCK	С	32	26	62
17	В	21	15	37	49	D	33	27	63
18	В	—	-	36	50	D	—	—	64
19	В	20	14	35	51	D	34	28	65
20	В	19	13	33	52	D	36	30	67
21	В	18	12	32	53	D	37	31	68
22	В	—		31	54	D	-	—	69
23	В	—		30	55	D		_	71
24	В	17	11	29	56/ TDO	D	38	32	73
25	В	16	10	25	57	D	39	33	75
26	В			23	58	D			76
27	В			21	59	D			79
28	В	_	_	20	60	D		_	80
29	В	_		19	61	D			81
30	В	14	8	17	62	D	40	34	83
31	В	_	_	16	63	D	_	_	84
32/ TMS	В	13	7	15	64	D/GCLK3	41	35	85

TABLE 1-7:I/O PINOUTS

ATF1504ASV/ATF1504ASVL



ATF1504ASV/ATF1504ASVL



FIGURE 1-12: OUTPUT SINK CURRENT VS. SUPPLY VOLTAGE



FIGURE 1-13:

OUTPUT SINK CURRENT VS. OUTPUT VOLTAGE (Vcc = 3.3V, TA = 25°C)





FIGURE 1-15:

INPUT CURRENT VS. INPUT VOLTAGE (Vcc = 3.3V, TA = 25°C)



2.0 PACKAGING INFORMATION

2.1 Package Marking Information



E2

44-Lead Plastic Leaded Chip Carrier (L) – Square [PLCC]

Note: For the most current package drawings, please see the Microchip Packaging Specification located at http://www.microchip.com/packaging



	Units		INCHES				
	Dimension Limits	MIN	NOM	MAX			
Number of Pins	N		44				
Pitch	е		.050				
Overall Height	A	.165	.172	.180			
Contact Height	A1	.090	.105	.120			
Molded Package to Contact	A2	.062	-	.083			
Standoff §	A3	.020	-	-			
Corner Chamfer	CH1	.042	-	.048			
Chamfers	CH2	-	-	.020			
Side Chamfer	CH3	.042	-	.056			
Overall Width	E	.685	.690	.695			
Overall Length	D	.685	.690	.695			
Molded Package Width	E1	.650	.653	.656			
Molded Package Length	D1	.650	.653	.656			
Footprint Width	E2	.582	.610	.638			
Footprint Length	D2	.582	.610	.638			
Lead Thickness	С	.0075	-	.0125			
Upper Lead Width	b1	.026	-	.032			
Lower Lead Width	b	.013	-	.021			

Notes:

1. Pin 1 visual index feature may vary, but must be located within the hatched area.

D2

2. § Significant Characteristic.

3. Dimensions D1 and E1 do not include mold flash or protrusions. Mold flash or protrusions shall not exceed .010" per side.

4. Dimensioning and tolerancing per ASME Y14.5M.

Microchip Technology Drawing C04-048B

44-Lead Plastic Leaded Chip Carrier (L) - Square [PLCC]

Note: For the most current package drawings, please see the Microchip Packaging Specification located at http://www.microchip.com/packaging



	INCHES			
Dimensior	Limits	MIN	NOM	MAX
Contact Pitch	E		.050 BSC	
Contact Pad Spacing	C1		.630	
Contact Pad Spacing	C2		.630	
Contact Pad Width (X44)	X1			.026
Contact Pad Length (X44)	Y1			.094

Notes:

1. Dimensioning and tolerancing per ASME Y14.5M

BSC: Basic Dimension. Theoretically exact value shown without tolerances.

Microchip Technology Drawing No. C04-2048A

44-Lead Plastic Thin Quad Flatpack (3EB) - 10x10x1.0 mm Body [TQFP] Atmel Legacy Global Package Code AIX

Note: For the most current package drawings, please see the Microchip Packaging Specification located at http://www.microchip.com/packaging





Microchip Technology Drawing C04-21019-3EB Rev A Sheet 1 of 2

44-Lead Plastic Thin Quad Flatpack (3EB) - 10x10x1.0 mm Body [TQFP] Atmel Legacy Global Package Code AIX

Note: For the most current package drawings, please see the Microchip Packaging Specification located at http://www.microchip.com/packaging



	l l	MILLIMETERS					
[[Dimension Limits	MIN	NOM	MAX			
Number of Terminals	N		44				
Pitch	е		0.80 BSC				
Overall Height	А	-	-	1.20			
Standoff	A1	0.05	-	0.15			
Molded Package Thickness	A2	0.95	1.00	1.05			
Overall Length	D		12.00 BSC				
Molded Package Length	D1		10.00 BSC				
Overall Width	E	12.00 BSC					
Molded Package Width	E1		10.00 BSC				
Terminal Width	b	0.30	-	0.45			
Terminal Thickness	С	0.09	-	0.20			
Terminal Length	L	0.45	0.60	0.75			
Footprint	L1		1.00 REF	-			
Lead Bend Radius	R1	0.08	-	-			
Lead Bend Radius	R2	0.08	-	0.20			
Foot Angle	θ	0°	3.5°	7°			
Lead Angle	θ1	0°	-	-			
Terminal-to-Exposed-Pad	Θ2	11°	12°	13°			

Notes:

1. Pin 1 visual index feature may vary, but must be located within the hatched area.

2. Dimensioning and tolerancing per ASME Y14.5M

BSC: Basic Dimension. Theoretically exact value shown without tolerances.

REF: Reference Dimension, usually without tolerance, for information purposes only.

Microchip Technology Drawing C04-21019-3EB Rev A Sheet 2 of 2

44-Lead Plastic Thin Quad Flatpack (3EB) - 10x10x1.0 mm Body [TQFP] Atmel Legacy Global Package Code AIX

Note: For the most current package drawings, please see the Microchip Packaging Specification located at http://www.microchip.com/packaging



RECOMMENDED LAND PATTERN

	Ν	MILLIMETERS			
Dimension	Dimension Limits				
Contact Pitch	0.80 BSC				
Contact Pad Spacing	C1		11.40		
Contact Pad Spacing	C2		11.40		
Contact Pad Width (X20)	X1			0.55	
Contact Pad Length (X20)	Y1			1.50	
Contact Pad to Center Pad (X20)	G1	0.25			

Notes:

1. Dimensioning and tolerancing per ASME Y14.5M

BSC: Basic Dimension. Theoretically exact value shown without tolerances.

Microchip Technology Drawing C04-23019-3EB Rev A

100-Lead Plastic Thin Quad Flatpack (PF) – 14x14x1 mm Body, 2.00 mm [TQFP]

Note: For the most current package drawings, please see the Microchip Packaging Specification located at http://www.microchip.com/packaging



Notes:

1. Pin 1 visual index feature may vary, but must be located within the hatched area.

2. Chamfers at corners are optional; size may vary.

3. Dimensions D1 and E1 do not include mold flash or protrusions. Mold flash or protrusions shall not exceed 0.25 mm per side.

4. Dimensioning and tolerancing per ASME Y14.5M.

BSC: Basic Dimension. Theoretically exact value shown without tolerances.

REF: Reference Dimension, usually without tolerance, for information purposes only.

Microchip Technology Drawing C04-110B

100-Lead Plastic Thin Quad Flatpack (PF) - 14x14x1 mm Body 2.00 mm Footprint [TQFP]

Note: For the most current package drawings, please see the Microchip Packaging Specification located at http://www.microchip.com/packaging



	MILLIMETERS			
Dimensio	MIN	NOM	MAX	
Contact Pitch	0.50 BSC			
Contact Pad Spacing	C1		15.40	
Contact Pad Spacing	C2		15.40	
Contact Pad Width (X100)	X1			0.30
Contact Pad Length (X100)	Y1			1.50
Distance Between Pads	G	0.20		

Notes:

1. Dimensioning and tolerancing per ASME Y14.5M

BSC: Basic Dimension. Theoretically exact value shown without tolerances.

Microchip Technology Drawing No. C04-2110B

APPENDIX A: REVISION HISTORY

Revision A (03/2019)

Updated to the Microchip template. Microchip DS20006185 replaces Atmel document 1409. Removed commercial temperature, 68-/84-lead PLCCs and 100-lead PQFP.

THE MICROCHIP WEBSITE

Microchip provides online support via our WWW site at www.microchip.com. This website is used as a means to make files and information easily available to customers. Accessible by using your favorite Internet browser, the website contains the following information:

- **Product Support** Data sheets and errata, application notes and sample programs, design resources, user's guides and hardware support documents, latest software releases and archived software
- General Technical Support Frequently Asked Questions (FAQ), technical support requests, online discussion groups, Microchip consultant program member listing
- Business of Microchip Product selector and ordering guides, latest Microchip press releases, listing of seminars and events, listings of Micro-chip sales offices, distributors and factory representatives

CUSTOMER CHANGE NOTIFICATION SERVICE

Microchip's customer notification service helps keep customers current on Microchip products. Subscribers will receive e-mail notification whenever there are changes, updates, revisions or errata related to a specified product family or development tool of interest.

To register, access the Microchip website at www.microchip.com. Under "Support", click on "Customer Change Notification" and follow the registration instructions.

CUSTOMER SUPPORT

Users of Microchip products can receive assistance through several channels:

- Distributor or Representative
- · Local Sales Office
- Field Application Engineer (FAE)
- Technical Support

Customers should contact their distributor, representative or Field Application Engineer (FAE) for support. Local sales offices are also available to help customers. A listing of sales offices and locations is included in the back of this document.

Technical support is available through the website at: http://microchip.com/support

PRODUCT IDENTIFICATION SYSTEM

To order or obtain information, e.g., on pricing or delivery, refer to the factory or the listed sales office.

PART NO.	<u>-xx</u>	¥	¥	<u>xxx</u>	<u>-D</u>	<u>(</u> 1)	Exa	amples	:	
	Speed Grade	Package Type	Temperature Range	Lead Count	Tape a Opti	nd Reel ion	a)	ATF15	504ASV-15JU4	4-T = Industrial temp., Tape and Reel, PLCC package.
							b)	ATF15	504ASV-15JU4	4 = Industrial temp., PLCC package.
Device:		1504ASV = 1504ASVL =				C	c)	ATF15	504ASV-15AU4	 Industrial temp., TQFP package.
Smood Credes	15	- 15	20 (100)				d)	ATF15	504ASV-15AU	100 = Industrial temp., TQFP package.
Speed Grade:	15 20		ns (tPD) ns (tPD)				e)	ATF15	504ASVL-20JU	I44-T = Industrial temp., Tape and Reel, TQFP package.
Package Type:	A J		FP (Thin Profile Place) CC (Plastic J-leade			kage)	f)	ATF15	504ASVL-20JU	l44 = Industrial temp., TQFP package.
			·		,		g)	ATF15	504ASVL-20AL	J44 = Industrial temp., TQFP package.
Temperature Range:	U	= -40	°C to +85°C (Indus	strial)			h)	ATF18	504ASV-15AU	100 = Industrial temp., TQFP package.
Lead Count:	44 100		4 Leads 00 Leads				Ν	lote 1:	the catalog identifier is	teel identifier only appears in part number description. This used for ordering purposes rinted on the device package.
Tape and Reel Option:	Blar T		dard packaging (tul and Reel ⁽¹⁾	be or tray)						your Microchip Sales Office availability with the Tape and

ORDERING INFORMATION

ATF1504ASV(L) Green Package Options (Pb/Halide-Free/RoHS Compliant)

tPD1 (ns)	tcop (ns)	fmax (MHz)	Ordering Code	Package	Operation Range
			ATF1504ASV-15AU44	44A	
15	15 9 100		ATF1504ASV-15JU44	44J	Industrial (-40°C to +85°C)
			ATF1504ASV-15AU100	100A	
			ATF1504ASVL-20AU44	44A	
20 12		12 83.3	ATF1504ASVL-20JU44	44J	Industrial (-40°C to +85°C)
			ATF1504ASVL-20AU100	100A	

Note the following details of the code protection feature on Microchip devices:

- · Microchip products meet the specification contained in their particular Microchip Data Sheet.
- Microchip believes that its family of products is one of the most secure families of its kind on the market today, when used in the intended manner and under normal conditions.
- There are dishonest and possibly illegal methods used to breach the code protection feature. All of these methods, to our knowledge, require using the Microchip products in a manner outside the operating specifications contained in Microchip's Data Sheets. Most likely, the person doing so is engaged in theft of intellectual property.
- Microchip is willing to work with the customer who is concerned about the integrity of their code.
- Neither Microchip nor any other semiconductor manufacturer can guarantee the security of their code. Code protection does not mean that we are guaranteeing the product as "unbreakable."

Code protection is constantly evolving. We at Microchip are committed to continuously improving the code protection features of our products. Attempts to break Microchip's code protection feature may be a violation of the Digital Millennium Copyright Act. If such acts allow unauthorized access to your software or other copyrighted work, you may have a right to sue for relief under that Act.

Information contained in this publication regarding device applications and the like is provided only for your convenience and may be superseded by updates. It is your responsibility to ensure that your application meets with your specifications. MICROCHIP MAKES NO REPRESENTATIONS OR WARRANTIES OF ANY KIND WHETHER EXPRESS OR IMPLIED, WRITTEN OR ORAL, STATUTORY OR OTHERWISE, RELATED TO THE INFORMATION, INCLUDING BUT NOT LIMITED TO ITS CONDITION, QUALITY, PERFORMANCE, MERCHANTABILITY OR FITNESS FOR PURPOSE. Microchip disclaims all liability arising from this information and its use. Use of Microchip devices in life support and/or safety applications is entirely at the buyer's risk, and the buyer agrees to defend, indemnify and hold harmless Microchip from any and all damages, claims, suits, or expenses resulting from such use. No licenses are conveyed, implicitly or otherwise, under any Microchip intellectual property rights unless otherwise stated.

Microchip received ISO/TS-16949:2009 certification for its worldwide headquarters, design and wafer fabrication facilities in Chandler and Tempe, Arizona; Gresham, Oregon and design centers in California and India. The Company's quality system processes and procedures are for its PIC® MCUs and dsPIC® DSCs, KEELOQ® code hopping devices, Serial EEPROMs, microperipherals, nonvolatile memory and analog products. In addition, Microchip's quality system for the design and manufacture of development systems is ISO 9001:2000 certified.

QUALITY MANAGEMENT SYSTEM CERTIFIED BY DNV = ISO/TS 16949=

Trademarks

The Microchip name and logo, the Microchip logo, AnyRate, AVR, AVR logo, AVR Freaks, BitCloud, chipKIT, chipKIT logo, CryptoMemory, CryptoRF, dsPIC, FlashFlex, flexPWR, Heldo, JukeBlox, KeeLoq, Kleer, LANCheck, LINK MD, maXStylus, maXTouch, MediaLB, megaAVR, MOST, MOST logo, MPLAB, OptoLyzer, PIC, picoPower, PICSTART, PIC32 logo, Prochip Designer, QTouch, SAM-BA, SpyNIC, SST, SST Logo, SuperFlash, tinyAVR, UNI/O, and XMEGA are registered trademarks of Microchip Technology Incorporated in the U.S.A. and other countries.

ClockWorks, The Embedded Control Solutions Company, EtherSynch, Hyper Speed Control, HyperLight Load, IntelliMOS, mTouch, Precision Edge, and Quiet-Wire are registered trademarks of Microchip Technology Incorporated in the U.S.A. Adjacent Key Suppression, AKS, Analog-for-the-Digital Age, Any Capacitor, AnyIn, AnyOut, BodyCom, CodeGuard, CryptoAuthentication, CryptoAutomotive, CryptoCompanion, CryptoController, dsPICDEM, dsPICDEM.net, Dynamic Average Matching, DAM, ECAN, EtherGREEN, In-Circuit Serial Programming, ICSP, INICnet, Inter-Chip Connectivity, JitterBlocker, KleerNet, KleerNet logo, memBrain, Mindi, MiWi, motorBench, MPASM, MPF, MPLAB Certified logo, MPLIB, MPLINK, MultiTRAK, NetDetach, Omniscient Code Generation, PICDEM, PICDEM, net, PICkit, PICtail, PowerSmart, PureSilicon, QMatrix, REAL ICE, Ripple Blocker, SAM-ICE, Serial Quad I/O, SMART-I.S., SQI, SuperSwitcher, SuperSwitcher II, Total Endurance, TSHARC, USBCheck, VariSense, ViewSpan, WiperLock, Wireless DNA, and ZENA are trademarks of Microchip Technology Incorporated in the U.S.A. and other countries.

SQTP is a service mark of Microchip Technology Incorporated in the U.S.A.

Silicon Storage Technology is a registered trademark of Microchip Technology Inc. in other countries.

GestIC is a registered trademark of Microchip Technology Germany II GmbH & Co. KG, a subsidiary of Microchip Technology Inc., in other countries.

All other trademarks mentioned herein are property of their respective companies.

© 2019, Microchip Technology Incorporated, All Rights Reserved. ISBN: 978-1-5224-4345-2



Worldwide Sales and Service

AMERICAS

Corporate Office 2355 West Chandler Blvd. Chandler, AZ 85224-6199 Tel: 480-792-7200 Fax: 480-792-7277 Technical Support: http://www.microchip.com/support Web Address:

www.microchip.com

Atlanta Duluth, GA Tel: 678-957-9614 Fax: 678-957-1455

Austin, TX Tel: 512-257-3370

Boston Westborough, MA Tel: 774-760-0087 Fax: 774-760-0088

Chicago Itasca, IL Tel: 630-285-0071 Fax: 630-285-0075

Dallas Addison, TX Tel: 972-818-7423 Fax: 972-818-2924

Detroit Novi, MI Tel: 248-848-4000

Houston, TX Tel: 281-894-5983

Indianapolis Noblesville, IN Tel: 317-773-8323 Fax: 317-773-5453 Tel: 317-536-2380

Los Angeles Mission Viejo, CA Tel: 949-462-9523 Fax: 949-462-9608 Tel: 951-273-7800

Raleigh, NC Tel: 919-844-7510

New York, NY Tel: 631-435-6000

San Jose, CA Tel: 408-735-9110 Tel: 408-436-4270

Canada - Toronto Tel: 905-695-1980 Fax: 905-695-2078

ASIA/PACIFIC

Australia - Sydney Tel: 61-2-9868-6733

China - Beijing Tel: 86-10-8569-7000

China - Chengdu Tel: 86-28-8665-5511 China - Chongqing

Tel: 86-23-8980-9588 China - Dongguan Tel: 86-769-8702-9880

China - Guangzhou Tel: 86-20-8755-8029

China - Hangzhou Tel: 86-571-8792-8115

China - Hong Kong SAR Tel: 852-2943-5100

China - Nanjing Tel: 86-25-8473-2460

China - Qingdao Tel: 86-532-8502-7355

China - Shanghai Tel: 86-21-3326-8000

China - Shenyang Tel: 86-24-2334-2829

China - Shenzhen Tel: 86-755-8864-2200

China - Suzhou Tel: 86-186-6233-1526

China - Wuhan Tel: 86-27-5980-5300 China - Xian

Tel: 86-29-8833-7252 China - Xiamen Tel: 86-592-2388138

China - Zhuhai Tel: 86-756-3210040

ASIA/PACIFIC

India - Bangalore Tel: 91-80-3090-4444

India - New Delhi Tel: 91-11-4160-8631 India - Pune

Tel: 91-20-4121-0141

Japan - Osaka Tel: 81-6-6152-7160

Japan - Tokyo Tel: 81-3-6880- 3770

Korea - Daegu Tel: 82-53-744-4301

Korea - Seoul Tel: 82-2-554-7200

Malaysia - Kuala Lumpur Tel: 60-3-7651-7906

Malaysia - Penang Tel: 60-4-227-8870

Philippines - Manila Tel: 63-2-634-9065

Singapore Tel: 65-6334-8870

Taiwan - Hsin Chu Tel: 886-3-577-8366

Taiwan - Kaohsiung Tel: 886-7-213-7830

Taiwan - Taipei Tel: 886-2-2508-8600

Thailand - Bangkok Tel: 66-2-694-1351 Vietnam - Ho Chi Minh

Tel: 84-28-5448-2100

Tel: 31-416-690399 Fax: 31-416-690340

EUROPE

Austria - Wels

Tel: 43-7242-2244-39

Tel: 45-4450-2828

Fax: 45-4485-2829

Tel: 358-9-4520-820

Tel: 33-1-69-53-63-20

Fax: 33-1-69-30-90-79

Germany - Garching

Tel: 49-2129-3766400

Germany - Heilbronn

Tel: 49-7131-67-3636

Germany - Karlsruhe

Fax: 49-89-627-144-44

Germany - Rosenheim

Tel: 49-8031-354-560

Israel - Ra'anana

Italy - Milan

Italy - Padova

Tel: 972-9-744-7705

Tel: 39-0331-742611

Fax: 39-0331-466781

Tel: 39-049-7625286

Netherlands - Drunen

Tel: 49-721-625370

Germany - Munich Tel: 49-89-627-144-0

Tel: 49-8931-9700

Germany - Haan

Finland - Espoo

France - Paris

Fax: 43-7242-2244-393

Denmark - Copenhagen

Norway - Trondheim Tel: 47-7288-4388

Poland - Warsaw Tel: 48-22-3325737

Romania - Bucharest Tel: 40-21-407-87-50

Spain - Madrid Tel: 34-91-708-08-90 Fax: 34-91-708-08-91

Sweden - Gothenberg Tel: 46-31-704-60-40

Sweden - Stockholm Tel: 46-8-5090-4654

UK - Wokingham Tel: 44-118-921-5800 Fax: 44-118-921-5820